Single Electron Charging in Optically Active Nanowire Quantum Dots

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ABSTRACT We report optical experiments of a charge tunable, single nanowire quantum dot subject to an electric field tuned by two independent voltages. First, we control tunneling events through an applied electric field along the nanowire growth direction. Second, we modify the chemical potential in the nanowire with a back-gate. We combine these two field-effects to isolate a single electron and independently tune the tunnel coupling of the quantum dot with the contacts. Such charge control is a first requirement for opto-electrical single electron spin experiments on a nanowire quantum dot.

KEYWORDS Nanowires, optically-active quantum dots, single electron charging, opto-electronics

Single, optically active quantum dots are widely investigated due to the ability to combine both single electron charging1–3 and single5 or entangled4 photon-emission, which are all key requirements for quantum information processing applications.5 Nanowire quantum dots (NW-QDs) offer additional functionalities over self-assembled quantum dots since they are embedded in a one-dimensional system instead of a three-dimensional host matrix. Therefore, the single electron (hole) transport channel is naturally aligned to the optically active quantum dot in the nanowire, advantageous for combining both quantum optics6 and transport.7–9 In addition, due to the small radial dimensions of the nanowires, electrostatic gate geometries are highly versatile7,8 and axial heterostructure design is not limited by strain. As an example, the combination of Si sections, which are free of nuclear spins, with optically addressable electronic levels in III–V materials is promising for extending electron spin storage times.10 Prior to the work presented here, we have shown that a single InAs0.25P0.75 quantum dot grown in an InP nanowire geometry is optically active, exhibits narrow emission lines, spin polarization memory effects,10 and can be embedded in a LED device geometry.11 Furthermore, it is predicted that NW-QDs are ideal sources of entangled photons due to the nanowire symmetry.12 Recently, an electron spin-to-charge conversion read-out scheme has been proposed,13 which is compatible with controlled storage of carriers up to microseconds.14 Such storage times are promising since single spins in self-assembled quantum dots (SA-QDs) have been initialized, coherently manipulated, and read-out within picosecond time scales.15,16 The proposed spin read-out scheme13 highly depends on the overall tunnel coupling between the SA-QD energy levels and the continuum, determined by the quantum dot-to-contact spatial separation, which is fixed during growth.17

In this letter, we present electrical control and optical read-out of the number of electrons residing in a single InAs0.25P0.75 quantum dot embedded in an InP nanowire. We first identify the neutral exciton by photocurrent spectroscopy. Second, we demonstrate that the electron number can be controlled by an electric field applied along the nanowire growth direction or by an electrostatic back-gate that modifies the overall potential landscape of the nanowire. Finally, we tune the tunnel coupling of the quantum dot to the leads independently of the charge state.

Our nanowires have a typical length of 4 µm and a tapered diameter of 20 nm at the apex versus 60 nm at the base (Figure 1a). The nanowires have no intentional doping. The InAs0.25P0.75 quantum dot is between 4–6 nm high and ~30 nm in diameter.10 The nanowires are contacted by a titanium (Ti) source and drain, while the p++-Si/SiO2 substrate forms a back-gate (Methods). Figure 1b presents the device geometry and circuit schematics. At the Ti-InP interface, the Fermi level is pinned ~200 meV below the InP conduction band.18 Therefore, Schottky barriers are formed and a source-drain voltage \( V_{sd} \) generates an electric field along the nanowire growth axis without inducing a high current (I < 8 pA at \( V_{sd} < 6 \) V). In addition, the charge density in the nanowire can be changed with the back-gate voltage \( V_g \).

Figure 1c presents the photoluminescence from a single NW-QD as a function of incident laser power under non-resonant continuous wave excitation and at \( V_{sd} = V_g = 0 \) V. Here, the quantum dot is expected to be negatively charged.
V served around 1.42 eV is due to InP carrier recombination.\textsuperscript{19} The s-shell emission consists of an excitonic and biexcitonic pair in the quantum dot s-shell. At higher excitation power, a second (p, 1.352 eV) and third (d, 1.361 eV) peak appear as the lower energy transitions in the PLE spectrum.\textsuperscript{19} Therefore, resonant photocurrent spectroscopy resonances are detected using the s-shell emission. Laser filter notches in the PLE spectrum, the InP and d-shell absorption resonances (the s-p orbital splitting) is determined by the quantum confined Stark effect, which will be presented later in Figure 2d. The corresponding integrated photoluminescence intensity is shown in Figure 1d. Above \( V_{sd} = 3.8 \) V, no photoluminescence is observed. In photocurrent spectroscopy, however, a resonance peak of \( \sim 8 \) pA is measured. In this bias regime, the applied electric field compensates for the Coulomb attraction of the electron–hole pair and in addition reduces the tunnel barriers. Therefore, the photoexcited carriers tunnel out of the quantum dot before undergoing radiative recombination. When reducing the bias to 3.5 V, a single emission peak emerges at the same energy of 1.3394 eV (line width 280 meV). The increase in photoemission coincides with a decrease in the resonant photocurrent, displaying the competition between photoemission (at rate \( \Gamma_{\text{rad}} \)) and carrier tunneling (at rate \( \Gamma_{\text{escape}} \)) from the same optical transition. The corresponding transitions are presented in Figure 2b (top). On the basis of the presented resonant photocurrent measurements, the optical transition at 1.3394 eV is identified as the neutral exciton \( X^0 \) involving single electron–hole pair recombination in the quantum dot s-shell.

The onset voltage for the \( X^0 \) resonant photocurrent is independent of the excitation intensity since the single exciton escape rate, \( \Gamma_{\text{escape}} \), is determined by the applied electric field across the nanowire (see one dimensional (1D) WKB model and photocurrent laser power dependence in Supporting Information). The photocurrent reduces slightly at a bias above \( V_{sd} = 4 \) V, as the \( X^0 \) resonance shifts due to the quantum confined Stark effect, which will be presented later in Figure 4d.

At approximately \( V_{sd} = 1.5 \) V, the \( X^0 \) emission quenches while a new peak appears at 1.3376 eV originating from exciton recombination in the presence of an electrostatically induced electron \( (X^-) \). For the \( X^- \) transition, no photocurrent resonance is observed. See Figure 2b (bottom) for an overview of the \( X^0 \) and \( X^- \) radiative and tunneling transitions at \( V_{sd} = 1.5 \) V. The photoluminescence transition between \( X^- \) and \( X^0 \) is governed by tunneling of the single electron (e\textsuperscript{−}) in the \( X^- \) final state, in which Coulomb interactions can be neglected (see WKB model in supporting material). The observed emission energy difference between \( X^- \) and \( X^0 \) (the \( X^- \) renormalization energy) is 2 meV for due to the Fermi level pinning at the nanowire surface.\textsuperscript{18} The exact determination of the number of excess charges residing in the quantum dot is determined below using resonant photocurrent experiments. In photoluminescence at low excitation power, a single peak is observed at 1.335 eV attributed to the recombination of a single electron–hole pair in the quantum dot s-shell. At higher excitation power, the s-shell emission consists of an excitonic and biexcitonic peak, described in more detail in reference.\textsuperscript{10} With increasing excitation power, a second (p, 1.352 eV) and third (d, 1.361 eV) peak appear as the lower energy transitions in the NW-QD become saturated. The broad emission peak observed around 1.42 eV is due to InP carrier recombination. Figure 1d presents a photoluminescence excitation (PLE) spectrum (blue line), obtained by integrating the s-shell photoluminescence intensity at various laser excitation energies. In the PLE spectrum, the InP and d-shell absorption resonances are detected using the s-shell emission. Laser filter constraints inhibit PLE measurements below 1.36 eV excitation energy. Therefore, resonant photocurrent spectroscopy (Figure 1d, red line) is performed to demonstrate resonant absorption in the s-, p-, and d-shells. Here, the photoexcited electron–hole (e\textsuperscript{−}h\textsuperscript{+}) pairs are separated by an applied bias of \( V_{sd} = 6 \) V. The energy difference between the s- and p-shell resonances (the s-p orbital splitting) is determined by the quantum dot radial confinement. The splitting is found to be 17 meV and is similar to InAs/InP SA-QDs of comparable size.\textsuperscript{20} To avoid screening of applied electric fields due to photoexcited carriers in the InP barrier region, photocurrent spectroscopy experiments are performed under quantum dot d-shell quasi resonant excitation (1.361 eV) in the remainder of this letter. The s-shell photocurrent resonance at \( V_{sd} = 6 \) V is found at 1.3394 eV excitation energy while the emission energy at \( V_{sd} = 0 \) V is found at 1.335 eV in Figure 1c.

In Figure 2a (top), photoluminescence from the quantum dot s-shell is presented as a function of \( V_{sd} \) in the bias range between 0 and 6 V. The corresponding integrated photoluminescence intensity is shown in Figure 2a (bottom). In addition, Figure 2a (bottom) compares the source-drain current in absence of illumination (black line) to the s-shell resonant photocurrent (red line), which is excited at the 1.3394 eV resonance presented in Figure 1d. Above \( V_{sd} = 3.8 \) V, no photoluminescence is observed. In photocurrent spectroscopy, however, a resonance peak of \( \sim 8 \) pA is measured. In this bias regime, the applied electric field compensates for the Coulomb attraction of the electron–hole pair and in addition reduces the tunnel barriers. Therefore, the photoexcited carriers tunnel out of the quantum dot before undergoing radiative recombination. When reducing the bias to 3.5 V, a single emission peak emerges at the same energy of 1.3394 eV (line width 280 meV). The increase in photoemission coincides with a decrease in the resonant photocurrent, displaying the competition between photoemission (at rate \( \Gamma_{\text{rad}} \)) and carrier tunneling (at rate \( \Gamma_{\text{escape}} \)) from the same optical transition. The corresponding transitions are presented in Figure 2b (top). On the basis of the presented resonant photocurrent measurements, the optical transition at 1.3394 eV is identified as the neutral exciton \( X^0 \) involving single electron–hole pair recombination in the quantum dot s-shell.

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our NW-QD, which is similar to calculations for SA-QDs of comparable dot diameter. Figure 2c presents the electron–hole Coulomb attraction energy $V_{eh}$ and the electron–electron Coulomb repulsion energy $V_{ee}$ inducing a $E_0 - E_1$ energy difference of $V_{ee} - V_{eh}$. The observed $X_1^-$ emission at lower energy implies that $V_{eh}$ (calculated to be 40–60 meV in InAs/InP NW-QDs) exceeds $V_{ee}$.

These Coulomb interactions affect the photoemission coexistence of $X_0$ and $X_1^-$ (from $V_{sd} = 0.5$ to 2 V) in Figure 2a via tunnel events in the photoexcited state. From Figure 2b (bottom) the mechanism for the $X_0^-$ and $X_1^-$ overlap can be understood. Two tunnel events are of importance: first, when the source-drain bias is increased, the tunnel probability ($\Gamma_{\text{discharge}}$) of the $X_1^-$ final state electron ($e^-$) through the triangular shaped tunnel barrier increases; second, the quantum dot can recharge via initial state tunneling ($\Gamma_{\text{charge}}$). The second charging event is driven by the quantum dot energy, which is higher in the $X_0^-$ initial state than in the initial state of $X_1^-$ due to Coulomb interactions (see Figure 2c). A low tunneling probability ($\Gamma_{\text{charge}} \sim \Gamma_{\text{rad}}$) can allow for $X_0^-$ recombination before an energetically favorable electron tunnels into the quantum dot to result in $X_1^-$ emission. In contrast, when the tunnel coupling is high ($\Gamma_{\text{charge}} > \Gamma_{\text{rad}}$), the quantum dot charge state can easily change to follow the chemical potential. Hence, at high tunnel coupling the $X_0^- - X_1^-$ transition is expected to be more abrupt.

Instead of controlling the electron number in our NW-QD by electric field induced tunnel events along the nanowire growth direction (source-drain bias), the back-gate potential can be utilized to tune the Fermi level in the nanowire with respect to the energy levels in the quantum dot. In Figure 3a, high-resolution photoluminescence spectra are presented as a function of back-gate voltage ($V_{sd} = 0$ V). At large negative back-gate bias ($V_g = -42$ V), $X_0^-$ is observed at 1.3394 eV. At $V_g = -35$ V, $X_1^-$ recombination appears in the optical spectrum while $X_0^-$ quenches. Here, the Fermi-level in the nanowire is aligned with the quantum dot electron s-shell. Reducing the large negative back-gate bias further results in an unstable regime of the optical spectra between $-20$ V and $+5$ V, indicating that the quantum dot
We attribute the two observed peaks at is 1 order of magnitude smaller than the higher energy peak. The intensity of the lower energy peak consists of two peaks. The intensity of the lower energy peak is expected to be lower than $X_t^2$ due to the number of possible final states. At $V_{sd} = V_g = 0 \text{ V}$, the quantum dot is charged with 2 extra electrons caused by the Fermi level pinning at the nanowire surface. At large positive back-gate voltages ($V_g \gg 15 \text{ V}$), the emission stabilizes and a peak (line width of 160 $\mu$eV) at 1.3359 eV is observed. We assign this line to $X^0$ involving s-shell exciton recombination in the presence of three additional electrons. Note that the observed emission line width is larger than expected from the exciton lifetime. Presumably the dynamics of the nanowire surface states cause inhomogeneous broadening of the emission lines.

In Figure 3c, high-resolution photoluminescence spectra are presented as a function of source-drain bias at a fixed back-gate voltage of $V_g = +54 \text{ V}$. At $V_{sd} = 0 \text{ V}$, $X^2$- emission is observed. When increasing the electric field along the nanowire elongation axis, the quantum dot discharges. Here, $X^0$, $X_2^2$, $X_1^2$, and $X^0$ emission are observed successively before quenching of the quantum dot photoluminescence at $V_{sd} = 4.7 \text{ V}$. It should be noted that $X_2^2$ emission is not observed here due to the lower intensity obtained for the source-drain sweep compared to the back-gate voltage sweep.

The back-gate and source-drain bias can now be combined to tune the charge density in the nanowire and control the quantum dot tunnel events. In Figure 4a–c, the quantum dot photoluminescence is plotted as a function of $V_{sd}$ for corresponding $V_g = -18$, 0, and $+18 \text{ V}$. Extracted from Figures 4a–c, we first study the effect of the back-gate bias on the observed $X^0$ quantum confined Stark effect (QCSE) in Figure 4d. When assuming a homogeneous electric field, $F = V_{sd}/l$ (with $l = 1.4 \mu \text{m}$, the electrode spacing), the QCSE shifts are determined to be $-1.5$, $-1.2$, and $-1.7 \mu$eV/cm$^2$V$^2$ for $V_g = -18$, 0, and $+18 \text{ V}$, respectively. These values are comparable to Stark shifts obtained in self-assembled InAs-InP quantum dots of similar quantum dot height. A more significant effect of the back-gate potential on the quantum dot emission is the observed coexistence of $X^0$ and $X^1$ quantum confined Stark effect (QCSE) in Figure 4a–c. Here, the NW-QD is tuned from a regime in which $X^0$ and $X^1$ are highly overlapping (for a range of $\sim2 \text{ V}$ in Figure 4a) to a regime in which the peaks are virtually nonoverlapping (Figure 4c) indicating that the tunnel coupling (i.e., $\Gamma_{\text{charge}}$ and $\Gamma_{\text{discharge}}$) from the quantum dot to the contacts is strongly modified. The graphic representation of the $X^0$ and $X^1$ emission in Figure 4e explicitly demonstrates that the coexistence is reduced with increasing back-gate bias voltage. The altered nanowire carrier-density by the back-gate changes the charge state of the quantum dot (Figure 3b) and in addition affects the transparency of the Schottky barriers, thus modifying the tunnel coupling. The reduced escape voltage of $X^0$ confirms the tunnel coupling enhancement. At this high tunnel coupling, we could estimate an electron charging energy of 8 meV, extracted from the length of the charge plateaus of $X^1$ (1.75 V) and $X^0$ (0.7 V) in a similar manner to the work of Seidl and co-workers. In contrast to that work, we also utilize the conduction band s-p orbital energy splitting (11.3 meV) to estimate a coupling strength (0.011) of the contacts to the quantum dot, which provides a relationship between the applied voltage and the electron charging energy. The s-p orbital energy splitting is estimated by assuming a 2:1 electron versus hole orbital energy ratio, which is determined for InAs/InP quantum dots. The total s-p orbital splitting of 1.7 meV was obtained from Figure 1c.

The tunability of the tunnel coupling in an optically active quantum dot enables the optimization of tunnel rates with respect to the exciton radiative lifetime, which is crucial for any electron spin-to-charge optical read-out scheme.

In conclusion, we have presented single electron charging in an optically active nanowire quantum dot. We showed by photoluminescence spectroscopy that the exciton charge
state was tuned by two independent mechanisms, electric field-induced tunneling along the nanowire growth axis and chemical potential tuning with a back-gate. We combined these two mechanisms to isolate a single electron within the optically active quantum dot and tune the quantum dot tunnel coupling with the contacts. The device geometry allows for addition of multiple lateral electrostatic gates to a single quantum dot. These results demonstrate that nanowire devices are promising for future single electron (spin) opto-electrical experiments such as coherent electrical spin manipulation followed by optical read-out and conversion of electron spin into photon polarization for long distance transfer of quantum information.

Methods. Nanowire Growth and Device Fabrication. The nanowire quantum dots were grown in the vapor–liquid–solid mode by means of metal–organic vapor-phase epitaxy in a similar manner as reported by Minot et al. Colloidal Au particles of 20 nm diameter were used to first grow an InP section for 20 min (~2 µm) followed by 1 s of InAsP growth. The ~4 µm long nanowires were completed by another 20 min of InP growth. By energy dispersive X-ray analysis in a transmission electron microscope, the dot size for 2 s of growth was estimated to be 9 ± 1 nm high and 33 ± 1 nm in diameter. After growth, the InP nanowires were transferred from the InP growth substrate to a prepatterned p++ silicon wafer with thermal oxide layer of 290 nm. Characterization by microphotoluminescence (µPL, see below) was done to select individual quantum dots with emission linewidths below 400 µeV. Nanowire identification and electrode positioning were done with the use of markers by optical microscope imaging. Electrode patterning was done by e-beam lithography. Before metal deposition, HF (6 s in 6:1 buffered HF) was used to remove the InP native oxide layer. The contacts consist of an evaporated titanium (110 nm)/gold (10 nm)
thin film. Out of 35 selected nanowires, 20 single nanowire quantum dots were successfully contacted.

Experimental Setup. µPL studies were performed at 4.2 K (Figures 1c, 3, and 4) and 10 K (Figure 2). The cryostat is mounted with electrical access and a computer controlled motorized stage. Optical excitation was performed with a diode laser (photon energy 2.35 eV) and a tunable titanium sapphire laser (photon tuning energy range of 1.24−1.77 eV). A 0.65 NA objective was used. The incident linear laser polarization was modified by a half-wave plate to align the linear polarization along the nanowire elongation axis to maximize the excitation efficiency. Detection of the emitted photons was achieved through a single grating spectrometer with a nitrogen-cooled CCD. The collection efficiency of the photons was achieved through a single grating spectrometer with a nitrogen-cooled CCD. The collection efficiency of the setup was ∼2%. Biases were applied using battery driven voltage sources, controlled by computer via an optical fiber enabling currents as low as 10 fA to be measured.

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Supporting Information Available. One dimensional WKB tunneling model and resonant photocurrent as a function of laser intensity. This material is available free of charge via the Internet at http://pubs.acs.org.

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